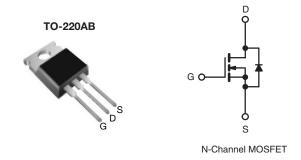


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	400			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.55		
Q _g (Max.) (nC)	36			
Q _{gs} (nC)	9.9			
Q _{gd} (nC)	16			
Configuration	Single			



FEATURES

• Low Gate Charge Qq Results in Simple Drive



 Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

TYPICAL SMPS TOPOLOGIES

- Single Transistor Flyback Xfmr. Reset
- Single Transistor Forward Xfmr. Reset (Both for US Line Input Only)

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF740APbF
	SiHF740A-E3
SnPb	IRF740A
	SiHF740A

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	400	V	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current	V -+ 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	1	10		
	V _{GS} at 10 V	T _C = 100 °C	I _D	6.3	Α	
Pulsed Drain Current ^a			I _{DM}	40		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	630	mJ	
Repetitive Avalanche Current ^a			I _{AR}	10	А	
Repetitive Avalanche Energy ^a			E _{AR}	12.5	mJ	
Maximum Power Dissipation	T _C =	25 °C	P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.9	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 12.6 mH, $R_g = 25$ Ω , $I_{AS} = 10$ A (see fig. 12). c. $I_{SD} \le 10$ A, $dV/dt \le 330$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST (CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	400	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I _D = 1 mA		0.48	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 30 V		-	-	± 100	nA
Zoro Gato Voltago Drain Current	l	V _{DS} = 400 V, V _{GS} = 0 V		-	-	25	5 µA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 320 \text{ V}, \text{ V}$	V _{DS} = 320 V, V _{GS} = 0 V, T _J = 125 °C		-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 6.0 \text{ A}^b$	-	-	0.55	Ω
Forward Transconductance	g _{fs}	V _{DS} = 50 V, I _D = 6.0 A ^b		4.9	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	1030	-	pF
Output Capacitance	C _{oss}			=	170	-	
Reverse Transfer Capacitance	C _{rss}			-	7.7	-	
Output Capacitance	Coss	$V_{GS} = 0 \text{ V}, V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$ $V_{GS} = 0 \text{ V}, V_{DS} = 320 \text{ V}, f = 1.0 \text{ MHz}$	-	1490	-		
Output Capacitance	Ooss		-	52	-		
Effective Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 0 V to 320 V		-	61	-	
Total Gate Charge	Q_g		$V_{GS} = 10 \text{ V}$ $I_D = 10 \text{ A}, V_{DS} = 320 \text{ V},$ see fig. 6 and 13 ^b	-	-	36	nC
Gate-Source Charge	Q_{gs}	$V_{GS} = 10 \text{ V}$		-	-	9.9	
Gate-Drain Charge	Q_{gd}		See lig. 6 dild 16		-	16]
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 200 V, I_{D} = 10 A, R_{g} = 10 Ω , R_{D} = 19.5 Ω , see fig. 10 ^b		-	10	-	
Rise Time	t _r			-	35	-	- ns
Turn-Off Delay Time	$t_{d(off)}$			-	24	-	
Fall Time	t _f			-	22	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	40	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S	$_{S} = 10 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 10 A, dl/dt = 100 A/µs ^b		-	240	360	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

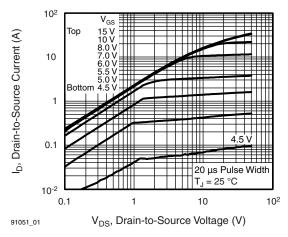


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

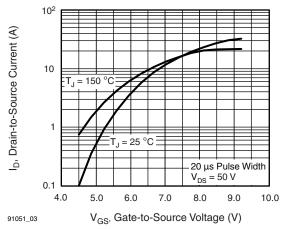


Fig. 3 - Typical Transfer Characteristics

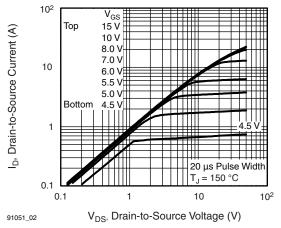


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

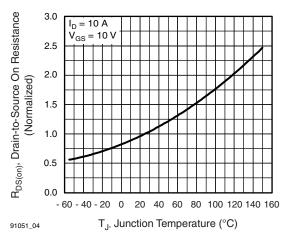


Fig. 4 - Normalized On-Resistance vs. Temperature



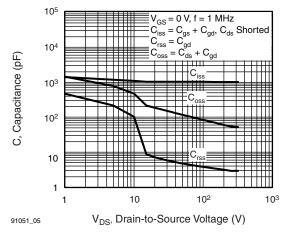


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

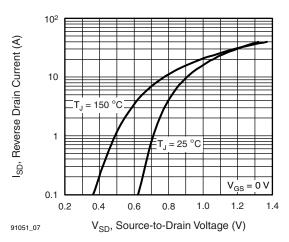


Fig. 7 - Typical Source-Drain Diode Forward Voltage

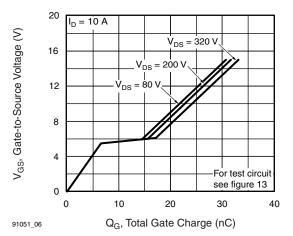


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

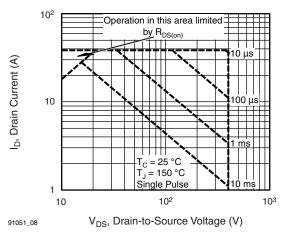


Fig. 8 - Maximum Safe Operating Area





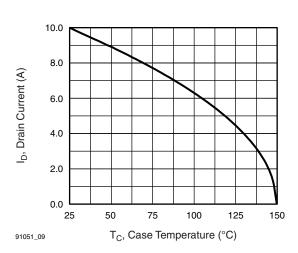


Fig. 9 - Maximum Drain Current vs. Case Temperature

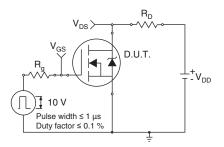


Fig. 10a - Switching Time Test Circuit

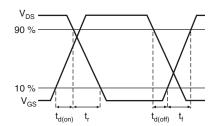


Fig. 10b - Switching Time Waveforms

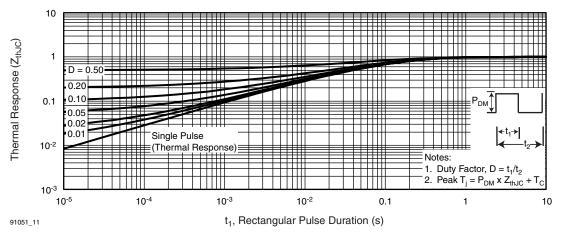


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

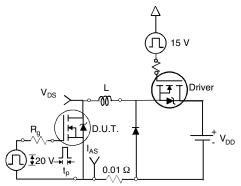


Fig. 12a - Unclamped Inductive Test Circuit

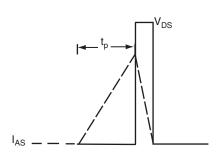


Fig. 12b - Unclamped Inductive Waveforms



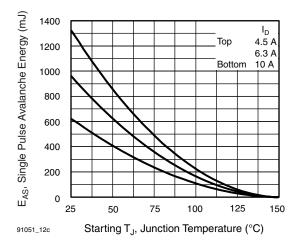


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

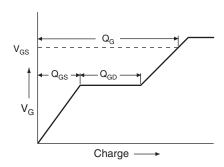


Fig. 13a - Basic Gate Charge Waveform

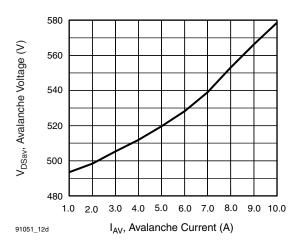


Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanche Current

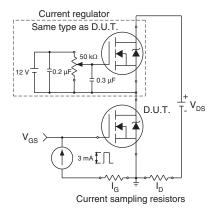
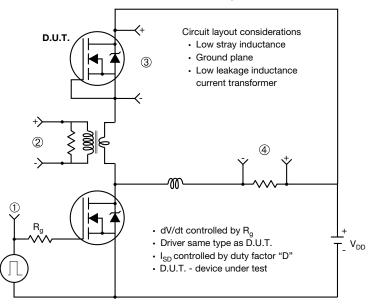


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



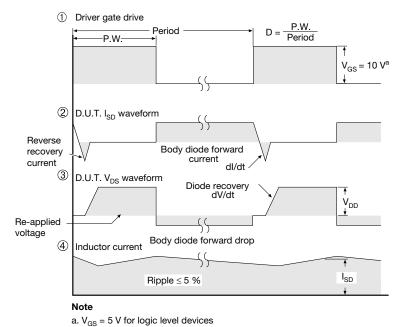


Fig. 14 - For N-Channel

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